Crystalfontz America, Inc.

SPECIFICATION

CUSTO	MER :			
MODUI	LE NO.:	CFAX12864	4T1-NFH	
	A DDD OUDD DW	CURCURE DV		
SALES BY	APPROVED BY	CHECKED BY	PREPARED BY	

ISSUED DATE:

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1. Module Classification Information

1	Brand: CRYSTALFONTZ AMERICA, INCORPORATED					
2	Display Type : H→Character Type, G→Graphic Type, X→TAB Type					
3	Display's logical dimensions: 128 pixels by 64 pixels					
4	Model variant: T (1 → module with ZIF tail)					
(5)	Backlight Type:	N→Without backlight	P→LED, Bule			
		B→EL, Blue green	A→LED, Amber			
		D→EL, Green	R→LED, Red			
		W→EL, White	O→LED, Orange			
		F→CCFL, White	G→LED, Green			
		Y→LED, Yellow Green	T→LED, White			
6	LCD Mode:	B→TN Positive, Gray	T→FSTN Negative			
		N→TN Negative,				
		G→STN Positive, Gray				
		Y→STN Positive, Yellow Green				
		M→STN Negative, Blue				
		F→FSTN Positive				
7	LCD Polarizer Type/	A→Reflective, N.T, 6:00	H→Transflective, W.T,6:00			
	Temperature range/ View direction	D→Reflective, N.T, 12:00	K→Transflective, W.T,12:00			
	view direction	G→Reflective, W. T, 6:00	C→Transmissive, N.T,6:00			
		J→Reflective, W. T, 12:00	F→Transmissive, N.T,12:00			
		B→Transflective, N.T,6:00	I→Transmissive, W. T, 6:00			
		E→Transflective, N.T.12:00	L→Transmissive, W.T,12:00			
8	Special Code	CB:				

2. Precautions in use of LCD Modules

- (1) Avoid applying excessive shocks to the module or making any alterations or modifications to it.
- (2) Don't make extra holes on the printed circuit board, modify its shape or change the components of LCD module.
- (3) Don't disassemble the LCM.
- (4) Don't operate it above the absolute maximum rating.
- (5) Don't drop, bend or twist LCM.
- (6) Soldering: only to the I/O terminals.
- (7) Storage: please storage in anti-static electricity container and clean environment.

3. General Specification

Item	Dimension	Unit
Number of Characters	128 x 64	_
Module dimension	36.5 x66.08 x1.6(MAX)	mm
View area	29.58x 17.98	mm
Active area	25.58x 15.98	mm
Dot size	0.23x 0.18	mm
Dot pitch	0.25 x 0.2	mm
LCD type	FSTN Positive Transflective (In LCD production, It will occur slightly color can only guarantee the same color in the same by	
Duty	1/64	
View direction	6 o'clock	
Backlight Type	Without backlight	

4. Absolute Maximum Ratings

Item	Symbol	Min	Тур	Max	Unit
Operating Temperature	T_{OP}	-20	_	+70	$^{\circ}\!\mathbb{C}$
Storage Temperature	T_{ST}	-30	_	+80	$^{\circ}\!\mathbb{C}$
Input Voltage	$V_{\rm I}$	V_{SS}	_	V_{DD}	V
Supply Voltage For Logic	V_{DD} - V_{SS}	1.8	_	3.6	V
Supply Voltage For LCD	Vout-V _{SS}	6.0	_	14.2	V

5. Electrical Characteristics

Item	Symbol	Condition	Min	Тур	Max	Unit
Supply Voltage For Logic	$ m V_{DD} ext{-}V_{SS}$	_	3.0	3.3	3.6	V
		Ta=-20°C	_		_	V
Supply Voltage For LCD	V_{DD} - V_{0UT}	Ta=25°℃	_	8.5	_	V
		Ta=70°C	_	_	_	V
Input High Volt.	V_{IH}	-	0.8 V _{DD}	_	V_{DD}	V
Input Low Volt.	V_{IL}	_	Vss	_	0.2 V _{DD}	V
Output High Volt.	V_{OH}	_	0.8 V _{DD}	_	V_{DD}	V
Output Low Volt.	V_{OL}		Vss	_	0.2 V _{DD}	V
Supply Current	I_{DD}	V _{DD} =3.3V	0.18	0.18	0.18	mA

6. Optical Characteristics

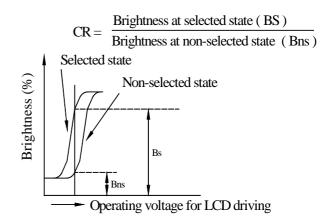
Item	Symbol	Condition	Min	Тур	Max	Unit
	(V) θ	CR≧2	30	_	60	deg
View Angle	(H) φ	CR≧2	-45	_	45	deg
Contrast Ratio	CR	_	_	5	_	_
	T rise	=	_	110	220	ms
Response Time	T fall	<u></u>	_	260	520	ms

6.1 Definitions

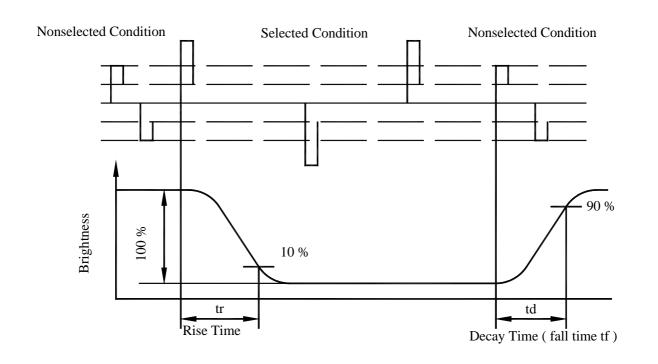
View Angles

Z (Visual angle direction) X_{\odot}

Contrast Ratio



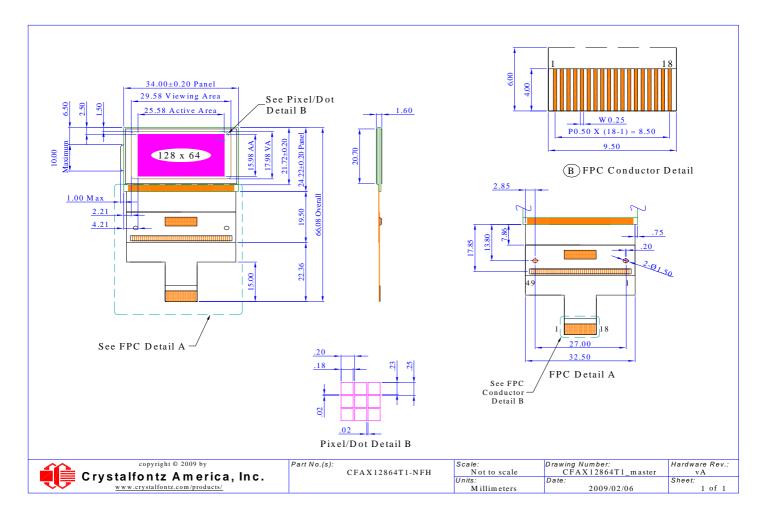
Response Time



7.Interface Description

Pin No.	Symbol	I/O	Descr	iption					
1	VDD	1/0	Power supply pin for logic.	ption					
2	VSS	_	Ground pin, connected to 0V						
3	CS1B	<u> </u>	Chip select input pins						
	0012	•	Data/instruction i/o is enabled only whe	n CS1Bis"L"and CS2"H"					
			When chip select is non-active,DB0 TC						
4	CS2	ı	Chip select input pins	DB / may be mgn impedance.					
1	002	ľ	Data/instruction i/o is enabled only who	n CS1Bis"L"and CS2"H".					
			When chip select is non-active,DB0 TC						
5	RES	ı	Reset input pin	7 0					
			When RESETB is "L", initialization is executed.						
			his is connected to the least significant bit of the normal MPU address bus,						
	4.0		and it determines whether the data bits	·					
6	A0	I	A0="H": Indicate that D0 to D7 are dis	olay data					
			A0="L": Indicate that D0 to D7 are con	trol data					
7	R/W	I	When connected to 80-family MPU:						
			Write enable clock input pin. The data of	ON DB0~DB7 are latched at the rising					
			lge of the /WR signal.						
			When connected to 68-family MPU:						
			RW = "H": read						
		1_	RW = "L": write						
8	E	I	When connected to 80-family MPU:						
			Read enable clock input pin. When /RD	is "L", DB0~DB7 are in an output					
			status						
			When connected to 68-family MPU:						
			RW = "H": When E is "H", DB0~DB7						
			RW = "L": The data on DB0~DB7 are l signal	atched at the failing edge of the E					
9-16	DB0-DB7	I/O	8-bit bi-directional data bus that is conr	ected to the standard 8-hit					
3-10	000-001	"	microprocessor data bus.	ected to the standard 6-bit					
			When the serial interface selected(PS='	L")					
			DB0~DB5: high impedance	2)					
			DB6: serial input clock (SCLK)						
			DB7: serial input data (SID)						
			When chip select is not active, DB0~Dl	37 may be high impedance.					
			This is the MPU interface switch termin	• •					
17	C86	I	C86 = "H":6800 Series MPU interface						
		1	C86 = "L":8080 Series MPU interface						
			This is the parallel data input/serial data	input switch terminal					
			P/S = "H":Parallel data input						
			<u>*</u>	P/S = "L":Serial data input					
			The following applies depending on the P/S status:						
			P/S Data/Command Data Read/Write Serial Clock						
18	P/S	I		"L"					
10	175	1	"H" A0 D0 to D7 /RD, /WR -						
			"L" A0 SI (D7) Write only SCL (D6)						
			When $P/S = L^*$, fix $D0 \sim D5$ pads to VD	D or VSS level. /RD(E) and /WR					
			(R/W) are fixed to either "H" or "L". With seral data input ,RAM display data						
			reading is not supported.	autu jan					
	<u> </u>	reading to not supported.							

8. Contour Drawing & Block Diagram



9. Fuction Description

Refer to IC NT7534 data sheet

10.RELIABILITY

Content of Reliability Test (wide temperature, -20°c~70°C)

Environmental Test						
Test Item	Content of Test	Test Condition	Note			
High Temperature storage	Endurance test applying the high storage temperature for a long time.	80°C 200hrs	2			
Low Temperature storage	Endurance test applying the high storage temperature for a long time.	-30℃ 200hrs	1,2			
High Temperature Operation	Endurance test applying the electric stress (Voltage & Current) and the thermal stress to the element for a long time.	70°C 200hrs				
Low Temperature Operation	Endurance test applying the electric stress under low temperature for a long time.	-20°ℂ 200hrs	1			
High Temperature/ Humidity Operation	The module should be allowed to stand at 60 °C,90%RH max For 96hrs under no-load condition excluding the polarizer, Then taking it out and drying it at normal temperature.	60°C,90%RH 96hrs	1,2			
Thermal shock resistance	The sample should be allowed stand the following 10 cycles of operation $ \begin{array}{ccccccccccccccccccccccccccccccccccc$	-20°C/70°C 10 cycles				
Vibration test	Endurance test applying the vibration during transportation and using.	Total fixed amplitude: 15mm Vibration Frequency: 10~55Hz One cycle 60 seconds to 3 directions of X,Y,Z for Each 15 minutes	3			
Static electricity test	Endurance test applying the electric stress to the terminal.	$VS=800V,RS=1.5k\Omega$ $CS=100pF$ 1 time				

Note1: No dew condensation to be observed.

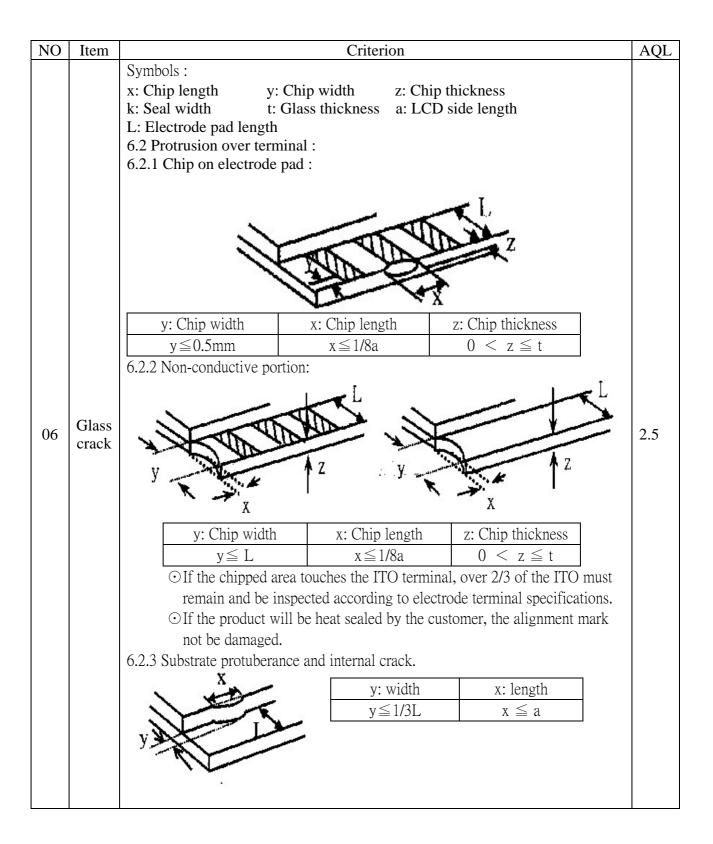
Note2: The function test shall be conducted after 4 hours storage at the normal Temperature and humidity after remove from the test chamber.

Note3: Vibration test will be conducted to the product itself without putting it in a container.

11. Inspection specification

NO	Item		Criterion				
01	Electrical Testing	1.2 Missing chara 1.3 Display malfu 1.4 No function of 1.5 Current consu 1.6 LCD viewing 1.7 Mixed production	 1.1 Missing vertical, horizontal segment, segment contrast defect. 1.2 Missing character, dot or icon. 1.3 Display malfunction. 1.4 No function or no display. 1.5 Current consumption exceeds product specifications. 1.6 LCD viewing angle defect. 1.7 Mixed product types. 1.8 Contrast defect. 				
02	Black or white spots on LCD (display only)	three white or	 2.1 White and black spots on display ≤0.25mm, no more than three white or black spots present. 2.2 Densely spaced: No more than two spots or lines within 3mm 				
03	LCD black spots, white spots,	3.1 Round type: $\Phi = (x + y) / X$		ing drawing SIZE $\Phi \leq 0$ $0.10 < \Phi \leq 0$ $0.20 < \Phi \leq 0$ $0.25 < \Phi$	0.20 2	2.5	
	contamination (non-display)	3.2 Line type : (A	As following Length L \leq 3.0 L \leq 2.5	$\begin{array}{c} \text{mg drawing)} \\ \text{Width} \\ \text{W} \leq 0.02 \\ 0.02 < \text{W} \leq 0.03 \\ 0.03 < \text{W} \leq 0.03 \\ 0.05 < \text{W} \end{array}$		2.5	
04	Polarizer bubbles	If bubbles are visible, judge using black spot specifications, no easy to find, mus check in specify direction.	0.50 < 1.00 <	Size Φ $\Phi \le 0.20$ $\Phi \le 0.50$ $\Phi \le 1.00$ Φ Total Φ	Acceptable Q TY Accept no dense 3 2 0 3	2.5	

NO	Item	Criterion				
05	Scratches	Follow NO.3 LCD black spots, white spots, contamination				
		k: Seal width t: L: Electrode pad length 6.1 General glass chip	: Glass thickness a: LCI n:	o thickness O side length anels:		
	China	z: Chip thickness $Z \le 1/2t$	y: Chip width Not over viewing area	x : Chip length $x \le 1/8a$		
06	Chipped glass	$1/2t < z \le 2t$	Not exceed 1/3k	x ≤ 1/8a	2.5	
		⊙ If there are 2 or more 6.1.2 Corner crack: z: Chip thickness	y: Chip width	x: Chip length		
		$Z \le 1/2t$	Not over viewing area	x≤1/8a		
ı		$1/2t < z \le 2t$	Not exceed 1/3k	x ≤ 1/8a		
		On there are 2 or more	chips, x is the total length	or cacif chip.		



NO	Item	Criterion	AQL
07	Cracked glass	The LCD with extensive crack is not acceptable.	2.5
08	Backlight elements	 8.1 Illumination source flickers when lit. 8.2 Spots or scratched that appear when lit must be judged. Using LCD spot, lines and contamination standards. 8.3 Backlight doesn't light or color wrong. 	0.65 2.5 0.65
09	Bezel	9.1 Bezel may not have rust, be deformed or have fingerprints, stains or other contamination.9.2 Bezel must comply with job specifications.	2.5 0.65
10	PCB、COB	 10.1 COB seal may not have pinholes larger than 0.2mm or contamination. 10.2 COB seal surface may not have pinholes through to the IC. 10.3 The height of the COB should not exceed the height indicated in the assembly diagram. 10.4 There may not be more than 2mm of sealant outside the seal area on the PCB. And there should be no more than three places. 10.5 No oxidation or contamination PCB terminals. 10.6 Parts on PCB must be the same as on the production characteristic chart. There should be no wrong parts, missing parts or excess parts. 10.7 The jumper on the PCB should conform to the product characteristic chart. 10.8 If solder gets on bezel tab pads, LED pad, zebra pad or screw hold pad, make sure it is smoothed down. 10.9 The Scraping testing standard for Copper Coating of PCB 	2.5 2.5 0.65 2.5 2.5 0.65 2.5 2.5 2.5
11	Soldering	 11.1 No un-melted solder paste may be present on the PCB. 11.2 No cold solder joints, missing solder connections, oxidation or icicle. 11.3 No residue or solder balls on PCB. 11.4 No short circuits in components on PCB. 	2.5 2.5 2.5 0.65

NO	Item	Criterion	AQL
12	General appearance	 12.1 No oxidation, contamination, curves or, bends on interface Pin (OLB) of TCP. 12.2 No cracks on interface pin (OLB) of TCP. 12.3 No contamination, solder residue or solder balls on product. 12.4 The IC on the TCP may not be damaged, circuits. 12.5 The uppermost edge of the protective strip on the interface pin must be present or look as if it causes the interface pin to sever. 12.6 The residual rosin or tin oil of soldering (component or chip component) is not burned into brown or black color. 12.7 Sealant on top of the ITO circuit has not hardened. 12.8 Pin type must match type in specification sheet. 12.9 LCD pin loose or missing pins. 12.10 Product packaging must the same as specified on packaging specification sheet. 12.11 Product dimension and structure must conform to product specification sheet. 	2.5 0.65 2.5 2.5 2.5 2.5 0.65 0.65 0.65 0.65

12. Material List of Components for RoHS

1. Crystalfontz America, Inc. hereby declares that all of or part of products, including, but not limited to, the LCM, accessories or packages, manufactured

and/or delivered to your company (including your subsidiaries and affiliated company) directly or indirectly by our company (including our subsidiaries or affiliated companies) do not intentionally contain any of the substances listed in all applicable EU directives and regulations, including the following substances.

Exhibit A: The Harmful Material List

Material	(Cd)	(Pb)	(Hg)	(Cr6+)	PBBs	PBDEs
Limited Value	100 ppm	1000 ppm	1000 ppm	1000 ppm	1000 ppm	1000 ppm
Above limited value is set up according to RoHS.						

2. Process for RoHS requirement:

- (1) Use the Sn/Ag/Cu soldering surface; the surface of Pb-free solder is rougher than we used before.
- (2) Heat-resistance temp. :

Reflow: 250°C,30 seconds Max.;

Connector soldering wave or hand soldering : 320°C, 10 seconds max.

(3) Temp. curve of reflow, max. Temp. : 235±5°C;

Recommended customer's soldering temp. of connector : 280°C, 3 seconds.